

Page 11, the paragraph at lines 10 through 11, please replace with the following:

--FIGs. 4(A), 4(B), and 4(C) illustrate to explain reference marks formed on a specimen or a reference template.--

Page 11, the paragraph at lines 23 through 25, please replace with the following:

--FIGs. 12(A) and 12(B) show differential operators for the process of sharpening an image of 3 x 3 pixels.--


REMARKS

Entry of the foregoing amendments prior to examination is respectfully requested. A marked-up version of the amended title and paragraphs, showing the changes made, are attached.

Respectfully submitted,

JUN 11 2002

Date



Richard L. Schwaab

Registration No. 25,479

FOLEY & LARDNER
3000 K Street, N.W. Suite 500
Washington, D.C. 20007-5109
(202) 672-5300

VERSIONS WITH MARKINGS TO SHOW CHANGES MADE

In the title:

AN ELECTRON BEAM DEVICE AND METHOD FOR [STREOSCOPIC]
STEREOSCOPIC MEASUREMENTS

Page 11, the paragraph at lines 2 through 4:

[FIG. 1 illustrates] FIGs. 1(A) and 1(B) illustrate to explain pictures taken at specified tilt angles of an object, a pattern of three straight lines of the identical length, placed at equal intervals.

Page 11, the paragraph at lines 5 through 6:

[FIG. 2 illustrates] FIGs. 2(A) and 2(B) illustrate to explain three-dimensional images obtained by rectification of the tilted images shown in FIGs. 1(A) and 1(B).

Page 11, the paragraph at lines 10 through 11:

[FIG. 4 illustrates] FIGs. 4(A), 4(B), and 4(C) illustrate to explain reference marks formed on a specimen or a reference template.

Page 11, the paragraph at lines 23 through 25:

[FIG. 12 shows] FIGs. 12(A) and 12(B) show differential operators for the process of sharpening an image of 3 x 3 pixels.